

<b>Notice of References Cited</b>	Application/Control No. 10/564,132		Applicant(s)/Patent Under Reexamination KIRIHARA ET AL.	
	Examiner ROBERT XU		Art Unit 1797	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0256384	11-2005	Walker et al.	600/316
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N					
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Uchimura, Tomohiro, et al. Resonance-enhanced Multiphoton Ionization Mass Spectrometry Using a Two-color Laser Beam Generated by Stimulated Raman Scattering, 2003, Analytical Science, Vol. 19, pages 387-389.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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